

Notice of References Cited

Application/Control No.

10/020,449

Applicant(s)/Patent Under

Reexamination

MIHAI ET AL.

Examiner

Y. J. Han

Art Unit

2838

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6368064	04-2002	Bendikas et al	363/41x
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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